

Notice of References Cited	Application/Control No. 10/549,926		Applicant(s)/Patent Under Reexamination GRUDIN ET AL.	
	Examiner Vuthe Siek		Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0101573	06-2003	Nelson et al.	29/612
*	B	US-2003/0062984	04-2003	Ito et al.	338/25
*	C	US-2002/0113127	08-2002	Takeuchi et al.	235/462.25
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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